EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
S1	1	wo-200291490-$.did.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/02/15 16:08
S2	38	(yasuhiko same kasama).in.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:28
S3	53	(kenji same omote).in.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:37
S4	1	(ideal same star).as.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:28
S5	0	"linear device" same "gate electrode" same "gate insulat$" same source same drain same semiconductor	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:40
S6	1	"linear device" same "gate electrode" same source same drain same semiconductor	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:39
S7	17	"linear device" same source same drain same semiconductor	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:39
S8	0	radial same "gate electrode" same "gate insulat$" same source same drain same semiconductor	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:40
S9	0	radial same "gate insulat$" same source same drain same semiconductor	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:40
S10	48	radial same source same drain same semiconductor	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:44
S11	2183	257/40.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:44
S12	27	257/40.ccls. and radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:47
S13	1440	257/401.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:47

S14	42	257/401.ccls. and radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:49
S15	848	257/410.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:47
S16	9	257/410.ccls. and radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:48
S17	54	257/E51.007.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:48
S18	0	257/E51.007.ccls. and radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:48
S19	166	257/E51.006.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:48
S20	118	257/E51.005.ccls.	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:48
S21	3	257/E51.006.ccls. and radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:48
S22	3	257/E51.005.ccls. and radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/15 16:48
S23	0	("2006/0208324").URPN.	USPAT	OR	ON	2007/02/15 16:53
S24	0	("2005/0253134").URPN.	USPAT	OR	ON	2007/02/15 20:36
S25	0	("2006/0162474").URPN.	USPAT	OR	ON	2007/02/15 20:36
S26	12913	semiconductor same drain same source same plurality	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/16 13:57
S27	6	semiconductor same drain same source same plurality same radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/16 13:57
S30	345	semiconductor same "plurality drain" same "plurality source"	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/16 13:59
S31	1	semiconductor same "plurality drain" same "plurality source" same radial	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/16 13:58
S32	11861759	@pd<"20040819"	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/16 13:59

S33	152	S30 and S32	US-PGPUB; USPAT; USOCR	OR	ON	2007/02/16 14:05
S34	2	jp-2004193437-$.did.	US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/02/16 14:06